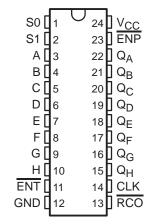
- Fully Programmable With Synchronous Counting and Loading
- SN74ALS867A and 'AS867 Have Asynchronous Clear; SN74ALS869 and 'AS869 Have Synchronous Clear
- Fully Independent Clock Circuit Simplifies Use
- Ripple-Carry Output for n-Bit Cascading
- Package Options Include Plastic Small-Outline (DW) Packages, Ceramic Chip Carriers (FK), and Standard Plastic (NT) and Ceramic (JT) 300-mil DIPs

description

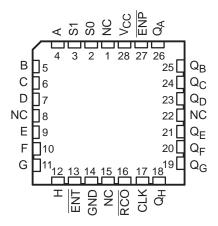
These synchronous, presettable, 8-bit up/down counters feature internal-carry look-ahead circuitry for cascading in high-speed counting applications. Synchronous operation is provided by having all flip-flops clocked simultaneously so that the outputs change coincidentally with each other when so instructed by the count-enable (ENP, ENT) inputs and internal gating. This mode of operation eliminates the output counting spikes normally associated with asynchronous (ripple-clock) counters. A buffered clock (CLK) input triggers the eight flip-flops on the rising (positive-going) edge of the clock waveform.

These counters are fully programmable; they may be preset to any number between 0 and 255. The load-input circuitry allows parallel loading of the cascaded counters. Because loading is synchronous, selecting the load mode disables the counter and causes the outputs to agree with the data inputs after the next clock pulse.

SN54AS867, SN54AS869 . . . JT PACKAGE SN74ALS867A, SN74ALS869, SN74AS867, SN74AS869 . . . DW OR NT PACKAGE (TOP VIEW)



SN54AS867, SN54AS869 . . . FK PACKAGE (TOP VIEW)



NC - No internal connection

The carry look-ahead circuitry provides for cascading counters for n-bit synchronous applications without additional gating. Two count-enable ($\overline{\text{ENP}}$ and $\overline{\text{ENT}}$) inputs and a ripple-carry ($\overline{\text{RCO}}$) output are instrumental in accomplishing this function. Both $\overline{\text{ENP}}$ and $\overline{\text{ENT}}$ must be low to count. The direction of the count is determined by the levels of the select (S0, S1) inputs as shown in the function table. $\overline{\text{ENT}}$ is fed forward to enable $\overline{\text{RCO}}$. $\overline{\text{RCO}}$ thus enabled produces a low-level pulse while the count is zero (all outputs low) counting down or 255 counting up (all outputs high). This low-level overflow-carry pulse can be used to enable successive cascaded stages. Transitions at $\overline{\text{ENP}}$ and $\overline{\text{ENT}}$ are allowed regardless of the level of CLK. All inputs are diode clamped to minimize transmission-line effects, thereby simplifying system design.

These counters feature a fully independent clock circuit. With the exception of the asynchronous clear on the SN74ALS867A and 'AS867, changes at S0 and S1 that modify the operating mode have no effect on the Q outputs until clocking occurs. For the 'AS867 and 'AS869, any time $\overline{\text{ENP}}$ and/or $\overline{\text{ENT}}$ is taken high, $\overline{\text{RCO}}$ either goes or remains high. For the SN74ALS867A and SN74ALS869, any time $\overline{\text{ENT}}$ is taken high, $\overline{\text{RCO}}$ either goes or remains high. The function of the counter (whether enabled, disabled, loading, or counting) is dictated solely by the conditions meeting the stable setup and hold times.



SN54AS867, SN54AS869 SN74ALS867A, SN74ALS869, SN74AS867, SN74AS869 SYNCHRONOUS 8-BIT UP/DOWN COUNTERS

SDAS115C - DECEMBER 1982 - REVISED JANUARY 1995

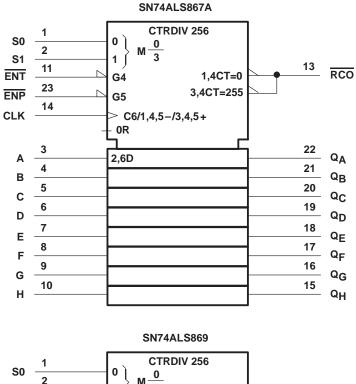
description (continued)

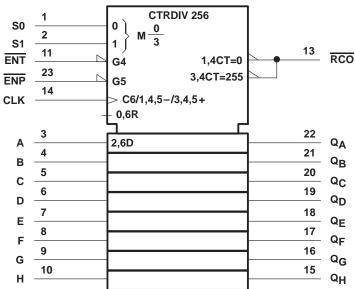
The SN54AS867 and SN54AS869 are characterized for operation over the full military temperature range of -55° C to 125°C. The SN74ALS867A, SN74ALS869, SN74AS867, and SN74AS869 are characterized for operation from 0°C to 70°C.

FUNCTION TABLE

S1	S0	FUNCTION
L	L	Clear
L	Н	Count down
Н	L	Load
Н	Н	Count up

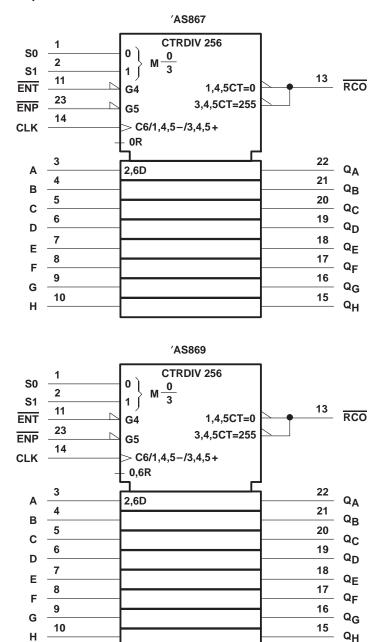
logic symbols†





[†] These symbols are in accordance with ANSI/IEEE Std 91-1984 and IEC Publication 617-12. Pin numbers shown are for the DW, JT, and NT packages.

logic symbols (continued)†

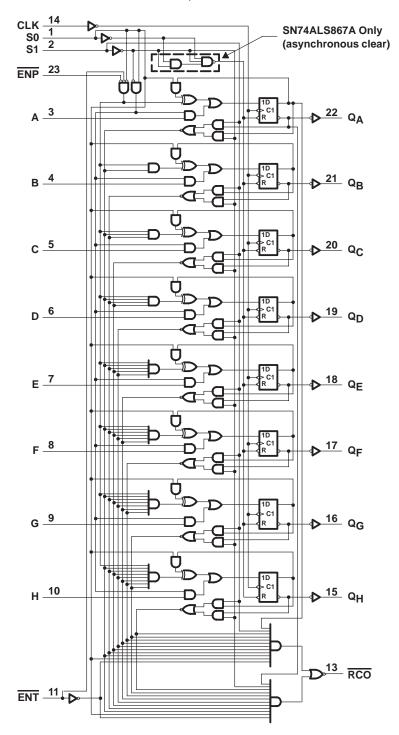


[†] These symbols are in accordance with ANSI/IEEE Std 91-1984 and IEC Publication 617-12. Pin numbers shown are for the DW, JT, and NT packages.



logic diagram (positive logic)

SN74ALS867A, SN74ALS869



Pin numbers shown are for the DW, JT, and NT packages.



logic diagram (positive logic)

SDAS115C - DECEMBER 1982 - REVISED JANUARY 1995

'AS867, 'AS869 'AS867 Only (asynchronous clear) ENT 11 13 RCO ENP 23 CLK 14 22 Q_A A -3 20 QC 19 Q_D D 17 QF 16 Q_G H ___________

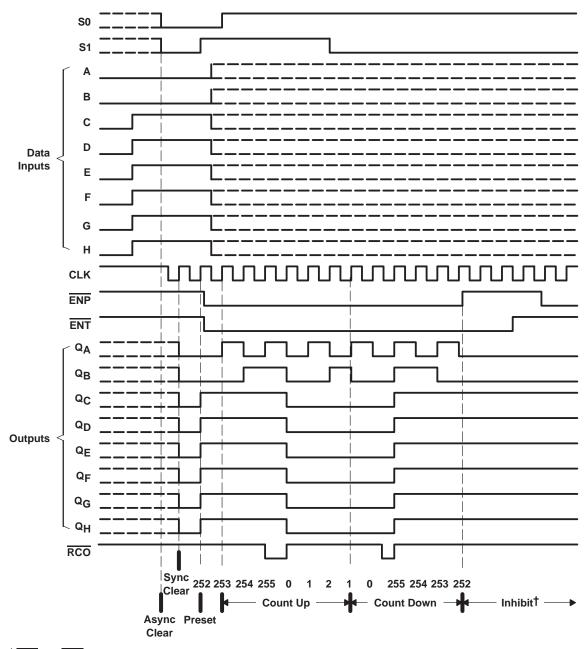
Pin numbers shown are for the DW, JT, and NT packages.



typical clear, preset, count, and inhibit sequences

The following sequence is illustrated below:

- 1. Clear outputs to zero (SN74ALS867A and 'AS867 are asynchronous; SN74ALS869 and 'AS869 are synchronous.)
- 2. Preset to binary 252
- 3. Count up to 253, 254, 255, 0, 1, and 2
- 4. Count down to 1, 0, 255, 254, 253, and 252
- 5. Inhibit



† ENT and ENP both must be low for counting to occur.



SN54AS867, SN54AS869 SN74ALS867A, SN74ALS869, SN74AS867, SN74AS869 SYNCHRONOUS 8-BIT UP/DOWN COUNTERS

SDAS115C - DECEMBER 1982 - REVISED JANUARY 1995

absolute maximum ratings over operating free-air temperature range (unless otherwise noted)

recommended operating conditions

			SN7	'4ALS86	7A	UNIT
			MIN	NOM	MAX	UNII
Vcc	Supply voltage		4.5	5	5.5	V
VIH	High-level input voltage		2			V
V _{IL}	Low-level input voltage				0.8	V
loн	High-level output current				-0.4	mA
loL	Low-level output current				8	mA
fclock	Clock frequency		0		35	MHz
tw(clock)	Pulse duration, CLK high or low		14			ns
tw(clear)	Pulse duration of clear pulse, S0 and S1 low		10			ns
		Data inputs A-H	10			
		ENP or ENT	15			
t _{su}	Setup time before CLK↑	S0 low and S1 high (load)	12			ns
		S0 high and S1 low (count down)	12			
		S0 and S1 high (count up)	12			
. .		S0 high after S1↑ or S1 high after S0↑	3			20
th	Hold time after CLK↑	Data inputs A-H	0			ns
TA	Operating free-air temperature		0		70	°C

electrical characteristics over recommended operating free-air temperature range (unless otherwise noted)

PARAMETER	TEST CON	IDITIONS	SN7	4ALS86	7A	UNIT
PARAMETER	TEST CON	TEST CONDITIONS			MAX	UNIT
VIK	$V_{CC} = 4.5 V$,	$I_{I} = -18 \text{ mA}$			-1.2	V
Voн	$V_{CC} = 4.5 \text{ V to } 5.5 \text{ V},$	$I_{OH} = -0.4 \text{ mA}$	V _{CC} -2	2		V
V _{OL}	Vac = 4.5.V	$I_{OL} = 4 \text{ mA}$		0.25	0.4	V
VOL	V _{CC} = 4.5 V	$I_{OL} = 8 \text{ mA}$		0.35	0.5	V
ΙĮ	$V_{CC} = 5.5 V,$	V _I = 7 V			0.1	mA
lін	$V_{CC} = 5.5 V,$	V _I = 2.7 V			20	μΑ
I _{IL}	$V_{CC} = 5.5 V,$	V _I = 0.4 V			-0.2	mA
ΙΟ§	$V_{CC} = 5.5 V,$	V _O = 2.25 V	-30		-112	mA
Icc	$V_{CC} = 5.5 V$			28	45	mA

[‡] All typical values are at $V_{CC} = 5 \text{ V}$, $T_A = 25^{\circ}\text{C}$.



[†] Stresses beyond those listed under "absolute maximum ratings" may cause permanent damage to the device. These are stress ratings only, and functional operation of the device at these or any other conditions beyond those indicated under "recommended operating conditions" is not implied. Exposure to absolute-maximum-rated conditions for extended periods may affect device reliability.

[§] The output conditions have been chosen to produce a current that closely approximates one half of the true short-circuit output current, IOS.

switching characteristics (see Figure 1)

PARAMETER	FROM (INPUT)	TO (OUTPUT)	$C_L = 50 \text{ pf}$ $R_L = 500 \Omega$ $T_A = MIN \Omega$	2,	UNIT
			MIN	MAX	
f _{max}			35		MHz
^t PLH	CLK	RCO	4	14	ns
^t PHL	GER	RCO	4	14	115
^t PLH	CLK	Any Q	3	16	ns
^t PHL	GER	Ally Q	3	16	115
^t PLH	ENT	RCO	3	14	ns
t _{PHL}	ENI	RCO	2	9	115
^t PHL	S0 or S1 (clear mode)	Any Q	8	26	ns
^t PLH	S0 or S1	RCO	4	16	no
^t PHL	(count up/down)		4	16	ns
^t PLH	S0 or S1 (clear mode)	RCO	4	16	ns

[†] For conditions shown as MIN or MAX, use the appropriate value specified under recommended operating conditions.

SN54AS867, SN54AS869 SN74ALS867A, SN74ALS869, SN74AS867, SN74AS869 SYNCHRONOUS 8-BIT UP/DOWN COUNTERS

SDAS115C - DECEMBER 1982 - REVISED JANUARY 1995

absolute maximum ratings over operating free-air temperature range (unless otherwise noted)†

recommended operating conditions

			SN	74ALS8	69	UNIT
			MIN	NOM	MAX	UNII
Vcc	Supply voltage		4.5	5	5.5	V
V _{IH}	High-level input voltage		2			V
V _{IL}	Low-level input voltage				0.8	V
loн	High-level output current				-0.4	mA
loL	Low-level output current				8	mA
fclock	Clock frequency		0		35	MHz
tw(clock)	Pulse duration, CLK high or low		14			ns
		Data inputs A-H	10			
		ENP or ENT	15			
١.	Outure there is a face OUKA	S0 and S1 low (clear)	13			
t _{su}	Setup time before CLK↑	S0 low and S1 high (load)	13			ns
		S0 high and S1 low (count down)	13			
		S0 and S1 high (count up)	13			
+,		S0 high after S1↑ or S1 high after S0↑	3			ns
th	Hold time after CLK↑ Data inputs A−H		0			115
TA	Operating free-air temperature		0		70	°C

electrical characteristics over recommended operating free-air temperature range (unless otherwise noted)

DADAMETED	TEST COM	IDITIONS	SN74ALS8	869	UNIT
PARAMETER	TEST CON	IDITIONS	MIN TYP‡	MAX	UNII
VIK	$V_{CC} = 4.5 V,$	I _I = -18 mA		-1.2	V
VOH	$V_{CC} = 4.5 \text{ V to } 5.5 \text{ V},$	$I_{OH} = -0.4 \text{ mA}$	V _{CC} -2		V
Va	V00 - 45 V	$I_{OL} = 4 \text{ mA}$	0.25	0.4	V
VoL	V _{CC} = 4.5 V	$I_{OL} = 8 \text{ mA}$	0.35	0.5	\ \ \
lį	$V_{CC} = 5.5 V,$	V _I = 7 V		0.1	mA
lіН	$V_{CC} = 5.5 V,$	V _I = 2.7 V		20	μΑ
Ι _Ι L	$V_{CC} = 5.5 V,$	V _I = 0.4 V		-0.2	mA
ΙΟ [§]	$V_{CC} = 5.5 V,$	V _O = 2.25 V	-30	-112	mA
lcc	V _{CC} = 5.5 V		28	45	mA

[‡] All typical values are at $V_{CC} = 5 \text{ V}$, $T_A = 25^{\circ}\text{C}$.



[†] Stresses beyond those listed under "absolute maximum ratings" may cause permanent damage to the device. These are stress ratings only, and functional operation of the device at these or any other conditions beyond those indicated under "recommended operating conditions" is not implied. Exposure to absolute-maximum-rated conditions for extended periods may affect device reliability.

[§] The output conditions have been chosen to produce a current that closely approximates one half of the true short-circuit output current, IOS.

switching characteristics (see Figure 1)

PARAMETER	FROM (INPUT)	TO (OUTPUT)	$V_{CC} = 4.5 \text{ V to } 5.5 \text{ V},$ $C_{L} = 50 \text{ pF},$ $R_{L} = 500 \Omega,$ $T_{A} = \text{MIN to MAX}^{\dagger}$ SN74ALS869 MIN MAX		UNIT
f _{max}			35		MHz
^t PLH	CLK	RCO	4	14	
t _{PHL}	CLK	RCO	4	14	ns
t _{PLH}	CLK	Any Q	3	16	ns
^t PHL	CLN	Ally Q	3	16	115
^t PLH	ENT	RCO	3	14	ns
[†] PHL	ENI	RCO	2	9	115
^t PLH	S1	RCO	4	15	ns
[†] PHL	(count up/down)	RCO	4	15	115
t _{PLH}	S0	RCO	4	16	ns
^t PHL	(clear/load)	, ROO	4	12	1115

[†] For conditions shown as MIN or MAX, use the appropriate value specified under recommended operating conditions.

SN54AS867, SN54AS869 SN74ALS867A, SN74ALS869, SN74AS867, SN74AS869 SYNCHRONOUS 8-BIT UP/DOWN COUNTERS

SDAS115C - DECEMBER 1982 - REVISED JANUARY 1995

absolute maximum ratings over operating free-air temperature range (unless otherwise noted)†

Supply voltage, V _{CC}	7 V
Input voltage, V _I	7 V
Operating free-air temperature range, T _A : SN54AS867	−55°C to 125°C
SN74AS867	0°C to 70°C
Storage temperature range	65°C to 150°C

[†] Stresses beyond those listed under "absolute maximum ratings" may cause permanent damage to the device. These are stress ratings only, and functional operation of the device at these or any other conditions beyond those indicated under "recommended operating conditions" is not implied. Exposure to absolute-maximum-rated conditions for extended periods may affect device reliability.

recommended operating conditions

			SI	N54AS86	7	SN	174AS86	7	UNIT
			MIN	NOM	MAX	MIN	NOM	MAX	UNII
Vcc	Supply voltage		4.5	5	5.5	4.5	5	5.5	V
VIH	High-level input voltage		2			2			V
V _{IL}	Low-level input voltage				0.8			0.8	V
loh	High-level output current				-2			-2	mA
loL	Low-level output current				20			20	mA
fclock*	Clock frequency		0		40	0		50	MHz
tw(clock)*	Pulse duration, CLK high or lo	w	12.5			10			ns
tw(clear)*	Pulse duration of clear pulse,	S0 and S1 low	12.5			10			ns
		Data inputs A-H	5			4			
		ENP or ENT	9			8			
. *	Octor for hetere OLKA	S0 low and S1 high (load)	11			10			no
t _{su} *	Setup time before CLK↑	S0 and S1 low (clear)	11			10			ns
		S0 high and S1 low (count down)	42			40			
		S0 and S1 high (count up)	42			40			
t _h *	Hold time after CLK↑	Data inputs A-H	0			0			ns
tskew*	Skew time between S0 and S (maximum to avoid inadverter				8			7	ns
TA	Operating free-air temperature	9	-55		125	0		70	°C

^{*} On products compliant to MIL-STD-883, Class B, this parameter is based on characterization data but is not production tested.



electrical characteristics over recommended operating free-air temperature range (unless otherwise noted)

	ARAMETER	TEST C	TEST CONDITIONS		N54AS86	57	SN	174AS86	7	UNIT	
	AKAMETEK	TEST CONDITIONS		MIN	TYP†	MAX	MIN	TYP†	MAX	UNIT	
٧ıK		$V_{CC} = 4.5 V,$	I _I = -18 mA			-1.2			-1.2	V	
Vон		$V_{CC} = 4.5 \text{ V to } 5.5 \text{ V},$	$I_{OH} = -2 \text{ mA}$	V _{CC} -2	2		V _{CC} -2			V	
VOL	RCO	V _{CC} = 4.5 V	$I_{OL} = 20 \text{ mA},$ $V_{IL} \text{ on } \overline{ENT} = 0.7 \text{ V}$		0.34	0.5				٧	
	Other outputs		I _{OL} = 20 mA					0.34 0.			
II		V _{CC} = 5.5 V,	V _I = 7 V			0.1			0.1	mA	
1	ENT	V	V _I = 2.7 V			40			40		
lіН	Other inputs	$V_{CC} = 5.5 \text{ V},$	V = 2.7 V			20			20	μΑ	
1	ENT	V 55V	V- 0.4.V			-4			-4	A	
¹ı∟	Other inputs	V _{CC} = 5.5 V,	V _I = 0.4 V		V = 0.4 V		-2	2		-2	mA
I _O ‡	-	V _{CC} = 5.5 V,	V _O = 2.25 V	-30		-112	-30		-112	mA	
Icc		V _{CC} = 5.5 V			134	195		134	195	mA	

[†] All typical values are at $V_{CC} = 5 \text{ V}$, $T_A = 25^{\circ}\text{C}$.

switching characteristics (see Figure 1)

PARAMETER	FROM (INPUT)	TO (OUTPUT)	C _L R _L	= 50 pF = 500 c	V to 5.5 ; , o MAX§	V,	UNIT
			SN54A	S867	SN74A	S867	
			MIN	MAX	MIN	MAX	
fmax*			40		50		MHz
^t PLH	CLK	RCO	5	31	5	22	ns
^t PHL	OLIX	RCO	6	19	6	16	115
^t PLH	CLK	Any Q	3	12	3	11	ns
[†] PHL		Ally Q	4	16	4	15	113
^t PLH	ENT	RCO	3	19	3	10	ns
^t PHL	ENI	RCO	5	21	5	17	115
t _{PLH}	ENP	RCO	5	16	5	14	ns
^t PHL	ENP	RCO	5	21	5	17	115
^t PHL	Clear (S0 or S1 low)	Any Q	7	23	7	21	ns

^{*} On products compliant to MIL-STD-883, Class B, this parameter is based on characterization data but is not production tested.



[‡] The output conditions have been chosen to produce a current that closely approximates one half of the true short-circuit output current, IOS.

[§] For conditions shown as MIN or MAX, use the appropriate value specified under recommended operating conditions.

SN54AS867, SN54AS869 SN74ALS867A, SN74ALS869, SN74AS867, SN74AS869 SYNCHRONOUS 8-BIT UP/DOWN COUNTERS

SDAS115C - DECEMBER 1982 - REVISED JANUARY 1995

absolute maximum ratings over operating free-air temperature range (unless otherwise noted)†

Supply voltage, V _{CC}		 $\dots \dots $
Input voltage, V _I		 7 V
Operating free-air temperature range, T _A :	SN54AS869	 . -55°C to 125°C
	SN74AS869	 0° C to 70° C
Storage temperature range		 . −65°C to 150°C

[†] Stresses beyond those listed under "absolute maximum ratings" may cause permanent damage to the device. These are stress ratings only, and functional operation of the device at these or any other conditions beyond those indicated under "recommended operating conditions" is not implied. Exposure to absolute-maximum-rated conditions for extended periods may affect device reliability.

recommended operating conditions

·			SN54AS869			SN74AS869			UNIT
			MIN	NOM	MAX	MIN	NOM	MAX	UNIT
Vcc	Supply voltage		4.5	5	5.5	4.5	5	5.5	V
V _{IH}	High-level input voltage		2			2			V
V _{IL}	Low-level input voltage				0.7			0.8	V
loн	High-level output current				-2			-2	mA
loL	Low-level output current			20			20	mA	
fclock*	Clock frequency				40			45	MHz
tw(clock)*	Pulse duration, CLK high or I	12.5			11			ns	
		Data inputs A-H	6			5			
		ENP or ENT	10			9			
. *	O	S0 low and S1 high (load)	13			11			
t _{su} *	Setup time before CLK↑	S0 and S1 low (clear)	13			11			ns
		S0 high and S1 low (count down)	52			50			
		S0 and S1 high (count up)	52			50			
t _h *	Hold time after CLK↑	Data inputs A-H	0			0			ns
TA	Operating free-air temperatu	re	-55		125	0		70	°C

^{*} On products compliant to MIL-STD-883, Class B, this parameter is based on characterization data but is not production tested.



electrical characteristics over recommended operating free-air temperature range (unless otherwise noted)

PARAMETER		TEST C	TEST CONDITIONS			SN54AS869			9	UNIT	
		TEST CONDITIONS			TYP [†]	MAX	MIN	TYP†	MAX	UNIT	
VIK		$V_{CC} = 4.5 V,$	I _I = -18 mA			-1.2			-1.2	V	
V		$V_{CC} = 4.5 \text{ V to } 5.5 \text{ V},$	$I_{OH} = -2 \text{ mA}$				V _{CC} -2	2		V	
VOH		$V_{CC} = 4.5 \text{ V},$	$V_{CC} = 4.5 \text{ V}, \qquad I_{OH} = -2 \text{ mA}$		2*					V	
V _{OL}	RCO	V _{CC} = 4.5 V	I _{OL} = 20 mA, V _{IL} on ENT = 0.7 V		0.34	0.5				V	
	Other outputs		I _{OL} = 20 mA				0.34 0.5		0.5	<u> </u>	
I _I		$V_{CC} = 5.5 V,$	V _I = 7 V			0.1			0.1	mA	
1	ENT	V00 - 5 5 V	V _I = 2.7 V			40			40	^	
lіН	Other inputs	V _{CC} = 5.5 V,	V = 2.7 V			20			20	μΑ	
1	ENT	V 55V	V _I = 0.4 V			-4			-4	mA	
IIL	Other inputs	V _{CC} = 5.5 V,	V = 0.4 V			-2			-2	IIIA	
IO [‡]		V _{CC} = 5.5 V,	V _O = 2.25 V	-30		-112	-30		-112	mA	
Icc	_	V _{CC} = 5.5 V			134	195		134	195	mA	

[†] All typical values are at $V_{CC} = 5 \text{ V}$, $T_A = 25^{\circ}\text{C}$.

switching characteristics (see Figure 1)

PARAMETER	FROM (INPUT)	TO (OUTPUT)	V _C C _L R _L T _A	UNIT			
	, ,	, ,	SN54A	\S869	SN74A	S869	
			MIN	MAX	MIN	MAX	
f _{max} *			40		45		MHz
^t PLH	CLK	RCO	6	35	6	35	ns
^t PHL	OLK	RCO	6	20	6	18	115
^t PLH	CLK	Any Q	3	12	3	11	ns
t _{PHL}	OLK	Ally Q	4	16	4	15	115
^t PLH	FNIT		3	25	3	15	ns
^t PHL	ENT	RCO	6	21	6	17	115
tPLH	ENP	RCO	5	27	5	19	ns
t _{PHL}	EINP	RCO	6	21	6	18	113

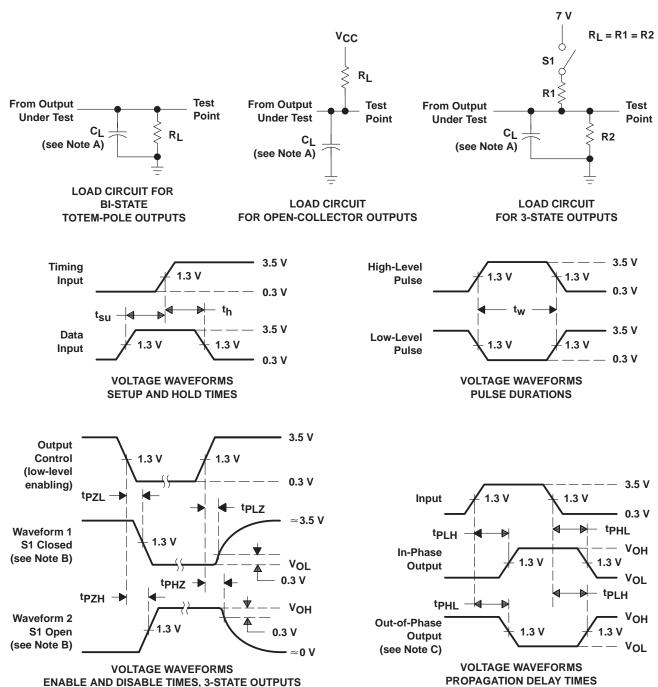
^{*} On products compliant to MIL-STD-883, Class B, this parameter is based on characterization data but is not production tested.



[‡] The output conditions have been chosen to produce a current that closely approximates one half of the true short-circuit output current, IOS.

[§] For conditions shown as MIN or MAX, use the appropriate value specified under recommended operating conditions.

PARAMETER MEASUREMENT INFORMATION SERIES 54ALS/74ALS AND 54AS/74AS DEVICES



NOTES: A. CL includes probe and jig capacitance.

- B. Waveform 1 is for an output with internal conditions such that the output is low except when disabled by the output control. Waveform 2 is for an output with internal conditions such that the output is high except when disabled by the output control.
- C. When measuring propagation delay items of 3-state outputs, switch S1 is open.
- D. All input pulses have the following characteristics: PRR \leq 1 MHz, $t_r = t_f = 2$ ns, duty cycle = 50%.
- E. The outputs are measured one at a time with one transition per measurement.

Figure 1. Load Circuits and Voltage Waveforms





PACKAGING INFORMATION

Orderable Device	Status ⁽¹⁾	Package Type	Package Drawing	Pins	Package Qty	e Eco Plan ⁽²⁾	Lead/Ball Finish	MSL Peak Temp ⁽³⁾
5962-89526013A	ACTIVE	LCCC	FK	28	1	TBD	POST-PLATE	N / A for Pkg Type
5962-8952601KA	ACTIVE	CFP	W	24	1	TBD	A42	N / A for Pkg Type
5962-8952601LA	ACTIVE	CDIP	JT	24	1	TBD	A42 SNPB	N / A for Pkg Type
5962-89668013A	ACTIVE	LCCC	FK	28	1	TBD	POST-PLATE	N / A for Pkg Type
5962-8966801KA	ACTIVE	CFP	W	24	1	TBD	A42	N / A for Pkg Type
5962-8966801LA	ACTIVE	CDIP	JT	24	1	TBD	A42 SNPB	N / A for Pkg Type
SN54AS867JT	ACTIVE	CDIP	JT	24	1	TBD	A42 SNPB	N / A for Pkg Type
SN54AS869JT	ACTIVE	CDIP	JT	24	1	TBD	A42 SNPB	N / A for Pkg Type
SN74ALS867ADW	ACTIVE	SOIC	DW	24	25	Green (RoHS & no Sb/Br)	CU NIPDAU	Level-1-260C-UNLIM
SN74ALS867ADWE4	ACTIVE	SOIC	DW	24	25	Green (RoHS & no Sb/Br)	CU NIPDAU	Level-1-260C-UNLIM
SN74ALS867ADWG4	ACTIVE	SOIC	DW	24	25	Green (RoHS & no Sb/Br)	CU NIPDAU	Level-1-260C-UNLIM
SN74ALS867ADWR	ACTIVE	SOIC	DW	24	2000	Green (RoHS & no Sb/Br)	CU NIPDAU	Level-1-260C-UNLIM
SN74ALS867ADWRE4	ACTIVE	SOIC	DW	24	2000	Green (RoHS & no Sb/Br)	CU NIPDAU	Level-1-260C-UNLIM
SN74ALS867ADWRG4	ACTIVE	SOIC	DW	24	2000	Green (RoHS & no Sb/Br)	CU NIPDAU	Level-1-260C-UNLIM
SN74ALS867ANT	ACTIVE	PDIP	NT	24	15	Pb-Free (RoHS)	CU NIPDAU	N / A for Pkg Type
SN74ALS867ANTE4	ACTIVE	PDIP	NT	24	15	Pb-Free (RoHS)	CU NIPDAU	N / A for Pkg Type
SN74ALS869DW	ACTIVE	SOIC	DW	24	25	Green (RoHS & no Sb/Br)	CU NIPDAU	Level-1-260C-UNLIM
SN74ALS869DWE4	ACTIVE	SOIC	DW	24	25	Green (RoHS & no Sb/Br)	CU NIPDAU	Level-1-260C-UNLIM
SN74ALS869DWG4	ACTIVE	SOIC	DW	24	25	Green (RoHS & no Sb/Br)	CU NIPDAU	Level-1-260C-UNLIM
SN74ALS869DWR	ACTIVE	SOIC	DW	24	2000	Green (RoHS & no Sb/Br)	CU NIPDAU	Level-1-260C-UNLIM
SN74ALS869DWRE4	ACTIVE	SOIC	DW	24	2000	Green (RoHS & no Sb/Br)	CU NIPDAU	Level-1-260C-UNLIM
SN74ALS869DWRG4	ACTIVE	SOIC	DW	24	2000	Green (RoHS & no Sb/Br)	CU NIPDAU	Level-1-260C-UNLIM
SN74ALS869NT	ACTIVE	PDIP	NT	24	15	Pb-Free (RoHS)	CU NIPDAU	N / A for Pkg Type
SN74ALS869NTE4	ACTIVE	PDIP	NT	24	15	Pb-Free (RoHS)	CU NIPDAU	N / A for Pkg Type
SN74AS867DW	ACTIVE	SOIC	DW	24	25	Green (RoHS & no Sb/Br)	CU NIPDAU	Level-1-260C-UNLIM
SN74AS867DWE4	ACTIVE	SOIC	DW	24	25	Green (RoHS & no Sb/Br)	CU NIPDAU	Level-1-260C-UNLIM
SN74AS867DWG4	ACTIVE	SOIC	DW	24	25	Green (RoHS & no Sb/Br)	CU NIPDAU	Level-1-260C-UNLIM
SN74AS867DWR	ACTIVE	SOIC	DW	24	2000	Green (RoHS & no Sb/Br)	CU NIPDAU	Level-1-260C-UNLIM





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Orderable Device	Status ⁽¹⁾	Package Type	Package Drawing	Pins	Packag Qty	e Eco Plan ⁽²⁾	Lead/Ball Finish	n MSL Peak Temp ⁽³⁾
SN74AS867DWRE4	ACTIVE	SOIC	DW	24	2000	Green (RoHS & no Sb/Br)	CU NIPDAU	Level-1-260C-UNLIM
SN74AS867DWRG4	ACTIVE	SOIC	DW	24	2000	Green (RoHS & no Sb/Br)	CU NIPDAU	Level-1-260C-UNLIM
SN74AS867NT	ACTIVE	PDIP	NT	24	15	Pb-Free (RoHS)	CU NIPDAU	N / A for Pkg Type
SN74AS867NT3	OBSOLETE	PDIP	NT	24		TBD	Call TI	Call TI
SN74AS867NTE4	ACTIVE	PDIP	NT	24	15	Pb-Free (RoHS)	CU NIPDAU	N / A for Pkg Type
SN74AS869DW	ACTIVE	SOIC	DW	24	25	Green (RoHS & no Sb/Br)	CU NIPDAU	Level-1-260C-UNLIM
SN74AS869DWE4	ACTIVE	SOIC	DW	24	25	Green (RoHS & no Sb/Br)	CU NIPDAU	Level-1-260C-UNLIM
SN74AS869DWG4	ACTIVE	SOIC	DW	24	25	Green (RoHS & no Sb/Br)	CU NIPDAU	Level-1-260C-UNLIM
SN74AS869DWR	ACTIVE	SOIC	DW	24	2000	Green (RoHS & no Sb/Br)	CU NIPDAU	Level-1-260C-UNLIM
SN74AS869DWRE4	ACTIVE	SOIC	DW	24	2000	Green (RoHS & no Sb/Br)	CU NIPDAU	Level-1-260C-UNLIM
SN74AS869DWRG4	ACTIVE	SOIC	DW	24	2000	Green (RoHS & no Sb/Br)	CU NIPDAU	Level-1-260C-UNLIM
SN74AS869NT	ACTIVE	PDIP	NT	24	15	Pb-Free (RoHS)	CU NIPDAU	N / A for Pkg Type
SN74AS869NT3	OBSOLETE	PDIP	NT	24		TBD	Call TI	Call TI
SN74AS869NTE4	ACTIVE	PDIP	NT	24	15	Pb-Free (RoHS)	CU NIPDAU	N / A for Pkg Type
SNJ54AS867FK	ACTIVE	LCCC	FK	28	1	TBD	POST-PLATE	N / A for Pkg Type
SNJ54AS867JT	ACTIVE	CDIP	JT	24	1	TBD	A42 SNPB	N / A for Pkg Type
SNJ54AS867W	ACTIVE	CFP	W	24	1	TBD	A42	N / A for Pkg Type
SNJ54AS869FK	ACTIVE	LCCC	FK	28	1	TBD	POST-PLATE	N / A for Pkg Type
SNJ54AS869JT	ACTIVE	CDIP	JT	24	1	TBD	A42 SNPB	N / A for Pkg Type
SNJ54AS869W	ACTIVE	CFP	W	24	1	TBD	A42	N / A for Pkg Type

⁽¹⁾ The marketing status values are defined as follows:

ACTIVE: Product device recommended for new designs.

LIFEBUY: TI has announced that the device will be discontinued, and a lifetime-buy period is in effect.

NRND: Not recommended for new designs. Device is in production to support existing customers, but TI does not recommend using this part in a new design.

PREVIEW: Device has been announced but is not in production. Samples may or may not be available.

OBSOLETE: TI has discontinued the production of the device.

TBD: The Pb-Free/Green conversion plan has not been defined.

Pb-Free (RoHS): TI's terms "Lead-Free" or "Pb-Free" mean semiconductor products that are compatible with the current RoHS requirements for all 6 substances, including the requirement that lead not exceed 0.1% by weight in homogeneous materials. Where designed to be soldered at high temperatures, TI Pb-Free products are suitable for use in specified lead-free processes.

Pb-Free (RoHS Exempt): This component has a RoHS exemption for either 1) lead-based flip-chip solder bumps used between the die and package, or 2) lead-based die adhesive used between the die and leadframe. The component is otherwise considered Pb-Free (RoHS compatible) as defined above.

Green (RoHS & no Sb/Br): TI defines "Green" to mean Pb-Free (RoHS compatible), and free of Bromine (Br) and Antimony (Sb) based flame retardants (Br or Sb do not exceed 0.1% by weight in homogeneous material)

⁽²⁾ Eco Plan - The planned eco-friendly classification: Pb-Free (RoHS), Pb-Free (RoHS Exempt), or Green (RoHS & no Sb/Br) - please check http://www.ti.com/productcontent for the latest availability information and additional product content details.



PACKAGE OPTION ADDENDUM

9-Oct-2007

(3) MSL, Peak Temp. -- The Moisture Sensitivity Level rating according to the JEDEC industry standard classifications, and peak solder temperature.

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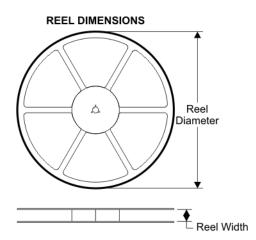
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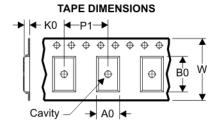




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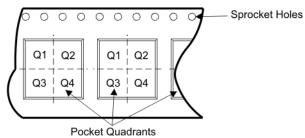
TAPE AND REEL BOX INFORMATION





	Dimension designed to accommodate the component width
	Dimension designed to accommodate the component length
K0	Dimension designed to accommodate the component thickness
	Overall width of the carrier tape
P1	Pitch between successive cavity centers

QUADRANT ASSIGNMENTS FOR PIN 1 ORIENTATION IN TAPE



Device	Package	Pins	Site	Reel Diameter (mm)	Reel Width (mm)	A0 (mm)	B0 (mm)	K0 (mm)	P1 (mm)	W (mm)	Pin1 Quadrant
SN74ALS867ADWR	DW	24	SITE 60	330	24	10.75	15.7	2.7	12	24	Q1
SN74ALS869DWR	DW	24	SITE 60	330	24	10.75	15.7	2.7	12	24	Q1
SN74AS867DWR	DW	24	SITE 60	330	24	10.75	15.7	2.7	12	24	Q1
SN74AS869DWR	DW	24	SITE 60	330	24	10.75	15.7	2.7	12	24	Q1





Device	Package	Pins	Site	Length (mm)	Width (mm)	Height (mm)
SN74ALS867ADWR	DW	24	SITE 60	346.0	346.0	41.0
SN74ALS869DWR	DW	24	SITE 60	346.0	346.0	41.0
SN74AS867DWR	DW	24	SITE 60	346.0	346.0	41.0
SN74AS869DWR	DW	24	SITE 60	346.0	346.0	41.0

JT (R-GDIP-T**)

24 LEADS SHOWN

CERAMIC DUAL-IN-LINE

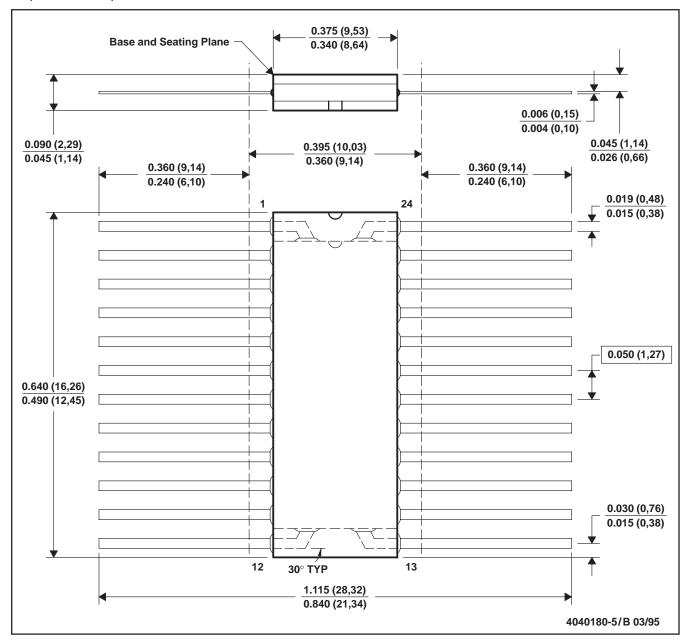


NOTES: A. All linear dimensions are in inches (millimeters).

- B. This drawing is subject to change without notice.
- C. This package can be hermetically sealed with a ceramic lid using glass frit.
- D. Index point is provided on cap for terminal identification.
- E. Falls within MIL STD 1835 GDIP3-T24, GDIP4-T28, and JEDEC MO-058 AA, MO-058 AB

W (R-GDFP-F24)

CERAMIC DUAL FLATPACK



- NOTES: A. All linear dimensions are in inches (millimeters).
 - B. This drawing is subject to change without notice.
 - C. This package can be hermetically sealed with a ceramic lid using glass frit.
 - D. Falls within MIL-STD-1835 GDFP2-F24 and JEDEC MO-070AD
 - E. Index point is provided on cap for terminal identification only.



FK (S-CQCC-N**)

28 TERMINAL SHOWN

LEADLESS CERAMIC CHIP CARRIER



NOTES: A. All linear dimensions are in inches (millimeters).

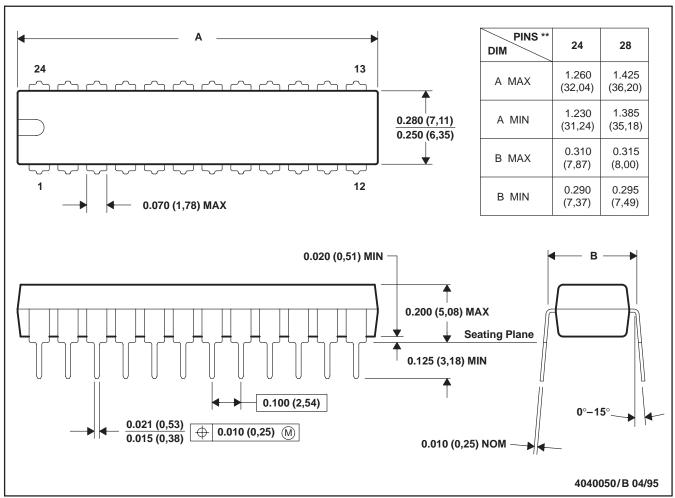
- B. This drawing is subject to change without notice.
- C. This package can be hermetically sealed with a metal lid.
- D. The terminals are gold plated.
- E. Falls within JEDEC MS-004



NT (R-PDIP-T**)

PLASTIC DUAL-IN-LINE PACKAGE

24 PINS SHOWN



NOTES: A. All linear dimensions are in inches (millimeters).

B. This drawing is subject to change without notice.

DW (R-PDSO-G24)

PLASTIC SMALL-OUTLINE PACKAGE



NOTES:

- A. All linear dimensions are in inches (millimeters).
- B. This drawing is subject to change without notice.
- C. Body dimensions do not include mold flash or protrusion not to exceed 0.006 (0,15).
- D. Falls within JEDEC MS-013 variation AD.



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